

Notice of References Cited	Application/Control No. 10/534,274	Applicant(s)/Patent Under Reexamination HIRANO ET AL.	
	Examiner Pablo N. Tran	Art Unit 2618	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,027,464	04-2006	Nakahara et al.	370/503
*	B	US-7,020,445	03-2006	Miya, Kazuyuki	455/101
*	C	US-7,177,266	02-2007	Sudo, Hiroaki	370/208
*	D	US-2003/0211851	11-2003	Moon et al.	455/450
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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